

<b>Notice of References Cited</b>	Application/Control No. 10/740,698		Applicant(s)/Patent Under Reexamination VARNER ET AL.	
	Examiner Benjamin Huh		Art Unit 3767	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,551,427	09-1996	Altman, Peter A.	600/374
*	C	US-5,868,697	02-1999	Richter et al.	604/8
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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